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|-----------------------------------|-------------------------|-----------------------------------------|-------------|
| Notice of References Cited | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | 10/623,284 | PITTEL ET AL. | |
| | Examiner | Art Unit | Page 1 of 1 |
| Leonid Shapiro | 2677 | | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|--------------------|----------------|
| * | A | US-6,100,538 | 08-2000 | Ogawa, Yasuji | 250/559.29 |
| * | B | US-5,572,607 | 11-1996 | Behrends, Rolf | 382/274 |
| * | C | US-4,682,016 | 07-1987 | Inoue, Toshiyuki | 235/462.49 |
| * | D | US-6,501,061 | 12-2002 | Kitai et al. | 250/205 |
| * | E | US-6,181,329 | 01-2001 | Stork et al. | 345/179 |
| * | F | US-6,856,349 | 02-2005 | Trevino, Roy | 348/302 |
| * | G | US-5,661,761 | 08-1997 | Iwamatsu, Takanori | 375/344 |
| * | H | US-5,227,732 | 07-1993 | Hong, Kwon-pyo | 327/558 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|------------------------------------------------------------------------------------------|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages |
| | U | |
| | V | |
| | W | |
| | X | |

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